1. Record Nr. UNINA9910299562903321 Autore Wu Yung-Chun Titolo 3D TCAD Simulation for CMOS Nanoeletronic Devices / / by Yung-Chun Wu, Yi-Ruei Jhan Singapore:,: Springer Singapore:,: Imprint: Springer,, 2018 Pubbl/distr/stampa **ISBN** 981-10-3066-9 Edizione [1st ed. 2018.] 1 online resource (XIII, 330 p. 243 illus., 240 illus. in color.) Descrizione fisica Disciplina 621.381 Soggetti **Electronics** Microelectronics Semiconductors Nanotechnology Industrial engineering Production engineering Electronics and Microelectronics, Instrumentation Nanotechnology and Microengineering Industrial and Production Engineering Lingua di pubblicazione Inglese **Formato** Materiale a stampa Livello bibliografico Monografia Nota di bibliografia Includes bibliographical references. Nota di contenuto Introduction of Synopsys Sentaurus TCAD 2014 version software environment operation interface and tools -- Simulation analysis of 2D MOSFET -- Simulation analysis of 3D FinFET with LG = 15 nm --Simulation analysis of Inverter and SRAM of 3D FinFET with LG = 15 nm -- Simulation analysis of GAA NWFET -- Simulation analysis of Junctionless FET with LG = 10 nm -- Simulation analysis of Tunnel FET -- Simulation analysis of Si and Ge 3D FinFET with LG = 3 nm. Sommario/riassunto This book demonstrates how to use the Synopsys Sentaurus TCAD 2014 version for the design and simulation of 3D CMOS (complementary metal-oxide-semiconductor) semiconductor nanoelectronic devices, while also providing selected source codes (Technology Computer-Aided Design, TCAD). Instead of the built-in

examples of Sentaurus TCAD 2014, the practical cases presented here,

based on years of teaching and research experience, are used to

interpret and analyze simulation results of the physical and electrical properties of designed 3D CMOSFET (metal–oxide–semiconductor field-effect transistor) nanoelectronic devices. The book also addresses in detail the fundamental theory of advanced semiconductor device design for the further simulation and analysis of electric and physical properties of semiconductor devices. The design and simulation technologies for nano-semiconductor devices explored here are more practical in nature and representative of the semiconductor industry, and as such can promote the development of pioneering semiconductor devices, semiconductor device physics, and more practically-oriented approaches to teaching and learning semiconductor engineering. The book can be used for graduate and senior undergraduate students alike, while also offering a reference guide for engineers and experts in the semiconductor industry. Readers are expected to have some preliminary knowledge of the field.